

P08 LTE B13\_QPSK10M\_Right Cheek\_Ch23230\_1RB\_OS24

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band    | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|---------|------------|---------------------------------|-------------------|------------------------|------------------|
| RightHead, -         | CHEEK, 0.00                  | Band 13 | LTE-FDD, - | 782.000, 23230                  | 10.21             | 0.898                  | 43.6             |

Hardware Setup

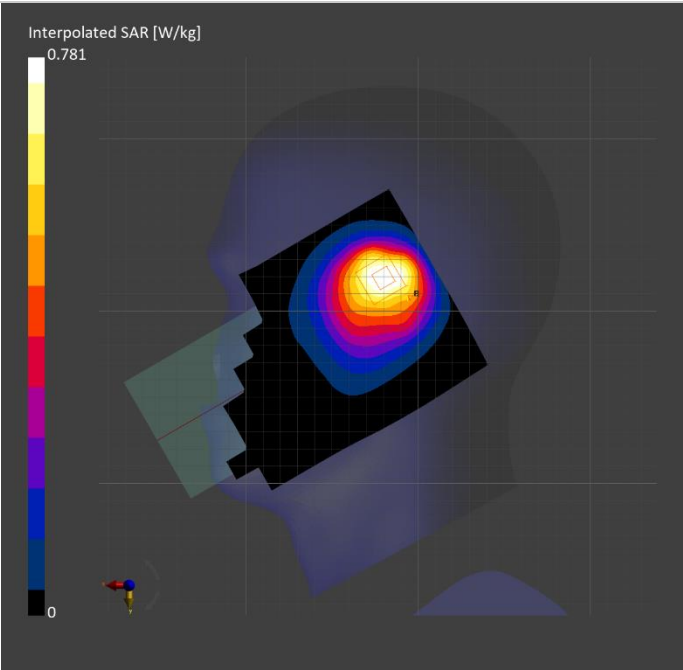
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL750-2025-04-25  | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 210.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 15.0 x 15.0   | 6.0 x 6.0 x 1.5    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.5                |
| MAIA                | N/A           | N/A                |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-25    | 2025-04-25    |
| psSAR1g [W/kg]      | 0.684         | 0.731         |
| psSAR10g [W/kg]     | 0.455         | 0.413         |
| Power Drift [dB]    | -0.01         | 0.00          |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 80.2          |
| Dist 3dB Peak [mm]  |               | 8.5           |



P09 LTE B26\_QPSK15M\_Right Cheek\_Ch26765\_36RB\_OS19

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band    | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|---------|------------|---------------------------------|-------------------|------------------------|------------------|
| RightHead, -         | CHEEK, 0.00                  | Band 26 | LTE-FDD, - | 821.500, 26765                  | 9.75              | 0.923                  | 43.4             |

Hardware Setup

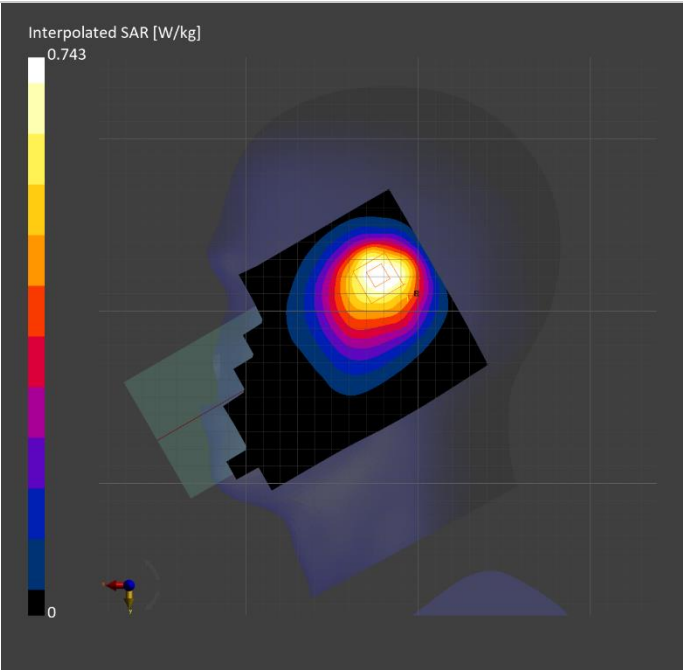
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL835-2025-04-21  | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 210.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 15.0 x 15.0   | 6.0 x 6.0 x 1.5    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.5                |
| MAIA                | N/A           | N/A                |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-21    | 2025-04-21    |
| psSAR1g [W/kg]      | 0.649         | 0.682         |
| psSAR10g [W/kg]     | 0.435         | 0.398         |
| Power Drift [dB]    | 0.00          | -0.03         |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 73.9          |
| Dist 3dB Peak [mm]  |               | 8.8           |



P10 LTE B41\_QPSK20M\_Right Tilted\_Ch40620\_50RB\_OS25

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band    | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|---------|------------|---------------------------------|-------------------|------------------------|------------------|
| RightHead, -         | TILT, 0.00                   | Band 41 | LTE-TDD, - | 2593.000, 40620                 | 7.57              | 1.94                   | 37.7             |

Hardware Setup

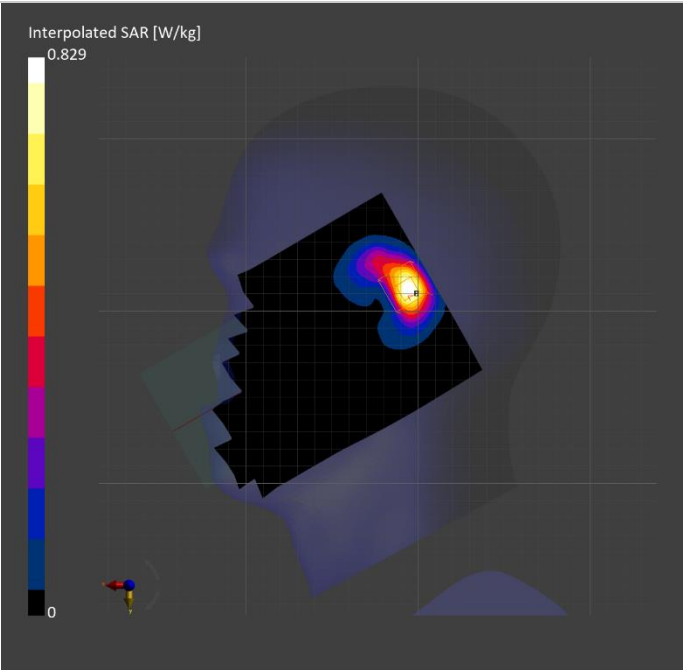
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL2550-2025-04-24 | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 200.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 10.0 x 10.0   | 5.0 x 5.0 x 1.5    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.5                |
| MAIA                | N/A           | N/A                |
| Surface Detection   | All points    | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-24    | 2025-04-24    |
| psSAR1g [W/kg]      | 0.624         | 0.711         |
| psSAR10g [W/kg]     | 0.289         | 0.298         |
| Power Drift [dB]    | 0.00          | 0.00          |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 79.4          |
| Dist 3dB Peak [mm]  |               | 6.4           |



P11 LTE B66\_QPSK20M\_Right Tilted\_Ch132072\_50RB\_OS25

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band    | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|---------|------------|---------------------------------|-------------------|------------------------|------------------|
| RightHead, -         | TILT, 0.00                   | Band 66 | LTE-FDD, - | 1720.000, 132072                | 8.6               | 1.32                   | 41.5             |

Hardware Setup

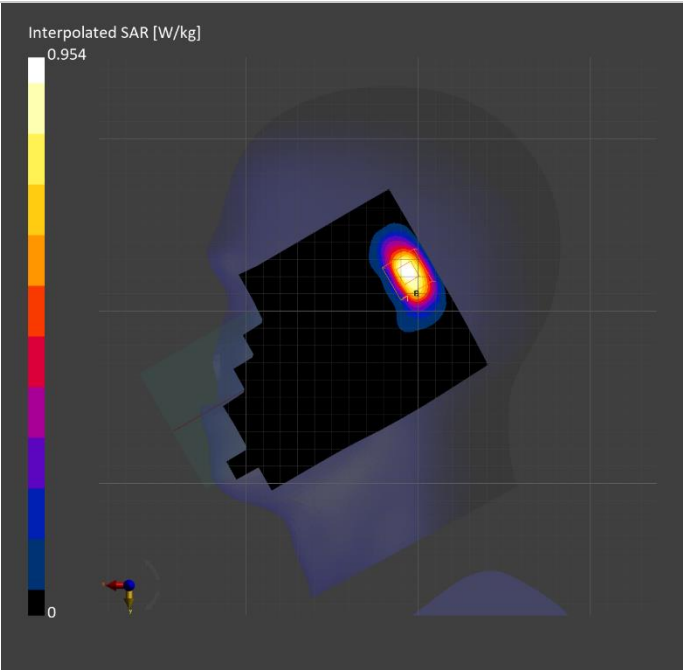
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL1750-2025-04-23 | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 210.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 15.0 x 15.0   | 6.0 x 6.0 x 1.5    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.5                |
| MAIA                | N/A           | N/A                |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-23    | 2025-04-23    |
| psSAR1g [W/kg]      | 0.749         | 0.808         |
| psSAR10g [W/kg]     | 0.370         | 0.381         |
| Power Drift [dB]    | -0.01         | 0.02          |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 80.2          |
| Dist 3dB Peak [mm]  |               | 7.2           |



P12 WLAN2.4G\_802.11b\_Left Cheek\_Ch1

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band        | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|-------------|------------|---------------------------------|-------------------|------------------------|------------------|
| LeftHead, -          | CHEEK, 0.00                  | WLAN 2.4GHz | WLAN, -    | 2412.000, 1                     | 7.7               | 1.79                   | 41.0             |

Hardware Setup

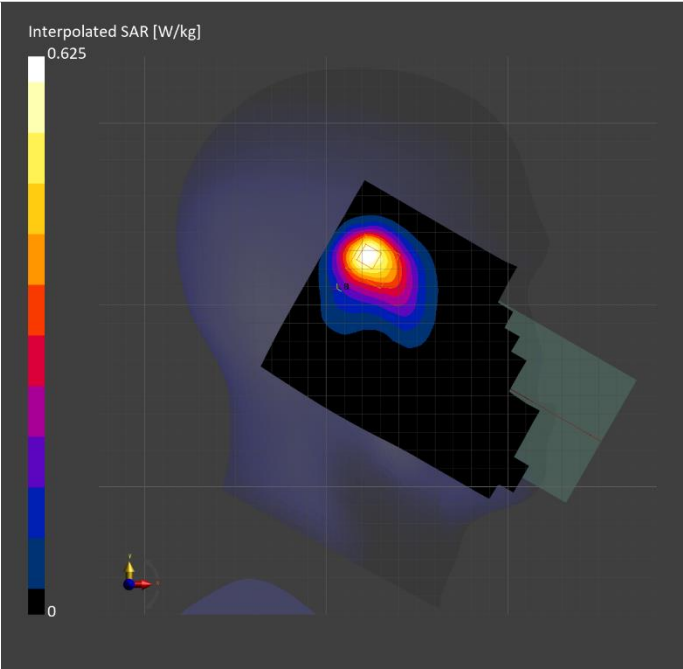
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL2450-2025-04-30 | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 200.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 10.0 x 10.0   | 5.0 x 5.0 x 1.5    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.5                |
| MAIA                | N/A           | N/A                |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-30    | 2025-04-30    |
| psSAR1g [W/kg]      | 0.485         | 0.467         |
| psSAR10g [W/kg]     | 0.248         | 0.240         |
| Power Drift [dB]    | -0.06         | -0.01         |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 83.4          |
| Dist 3dB Peak [mm]  |               | 8.1           |



P13 WLAN5G\_802.11a\_Left Titted\_Ch60

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band      | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|-----------|------------|---------------------------------|-------------------|------------------------|------------------|
| LeftHead, -          | TILT, 0.00                   | WLAN 5GHz | WLAN, -    | 5300.000, 60                    | 4.99              | 4.65                   | 36.2             |

Hardware Setup

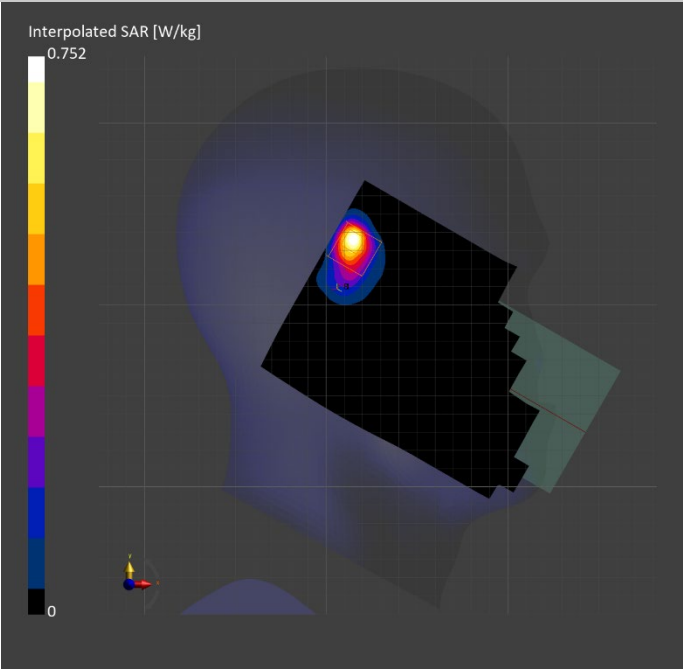
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL5G-2025-04-29   | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 200.0 | 22.0 x 22.0 x 22.0 |
| Grid Steps [mm]     | 10.0 x 10.0   | 4.0 x 4.0 x 1.4    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.4                |
| MAIA                | Y             | N/A                |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-29    | 2025-04-29    |
| psSAR1g [W/kg]      | 0.479         | 0.502         |
| psSAR10g [W/kg]     | 0.157         | 0.139         |
| Power Drift [dB]    | -0.43         | 0.11          |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 62.5          |
| Dist 3dB Peak [mm]  |               | 6.3           |



P14 WLAN5G\_802.11a\_Left Tilted\_Ch100

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band      | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|-----------|------------|---------------------------------|-------------------|------------------------|------------------|
| LeftHead, -          | TILT, 0.00                   | WLAN 5GHz | WLAN, -    | 5500.000, 100                   | 4.65              | 4.88                   | 35.8             |

Hardware Setup

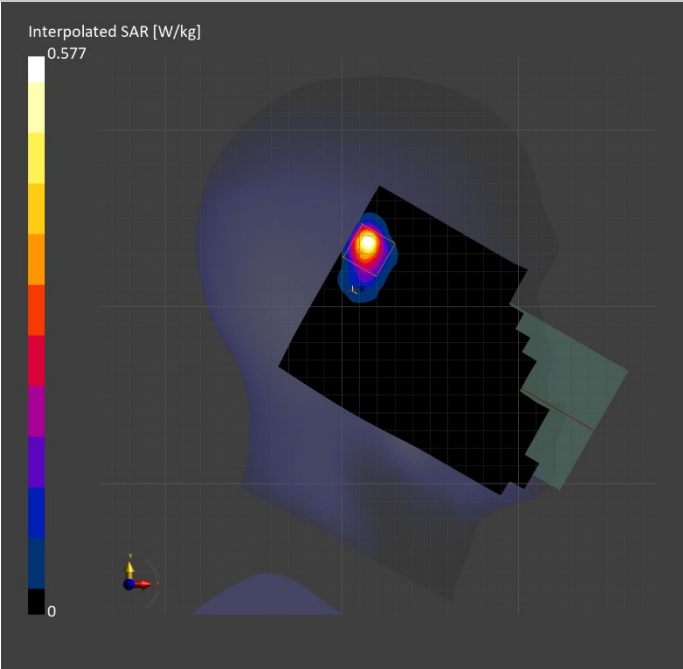
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL5G-2025-04-29   | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 200.0 | 22.0 x 22.0 x 22.0 |
| Grid Steps [mm]     | 10.0 x 10.0   | 4.0 x 4.0 x 1.4    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.4                |
| MAIA                | Y             | Y                  |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-29    | 2025-04-29    |
| psSAR1g [W/kg]      | 0.359         | 0.402         |
| psSAR10g [W/kg]     | 0.110         | 0.104         |
| Power Drift [dB]    | 0.02          | 0.12          |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 63.6          |
| Dist 3dB Peak [mm]  |               | 5.8           |



P15 WLAN5G\_802.11a\_Left Tilted\_Ch149

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band      | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|-----------|------------|---------------------------------|-------------------|------------------------|------------------|
| LeftHead, -          | TILT, 0.00                   | WLAN 5GHz | WLAN, -    | 5745.000, 149                   | 4.76              | 5.17                   | 35.4             |

Hardware Setup

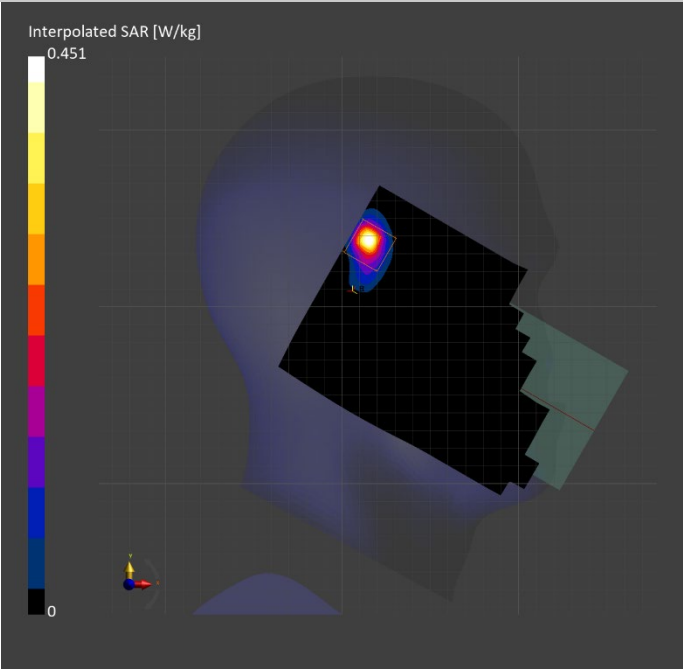
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL5G-2025-04-30   | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 200.0 | 22.0 x 22.0 x 22.0 |
| Grid Steps [mm]     | 10.0 x 10.0   | 4.0 x 4.0 x 1.4    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.4                |
| MAIA                | Y             | Y                  |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-30    | 2025-04-30    |
| psSAR1g [W/kg]      | 0.270         | 0.310         |
| psSAR10g [W/kg]     | 0.076         | 0.073         |
| Power Drift [dB]    | 0.22          | 0.02          |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 56.9          |
| Dist 3dB Peak [mm]  |               | 5.7           |



P16 BT\_GFSK\_Left Cheek\_Ch39

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band             | Group, UID   | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|------------------|--------------|---------------------------------|-------------------|------------------------|------------------|
| LeftHead, -          | CHEEK, 0.00                  | ISM 2.4 GHz Band | Bluetooth, - | 2441.000, 39                    | 7.7               | 1.84                   | 37.9             |

Hardware Setup

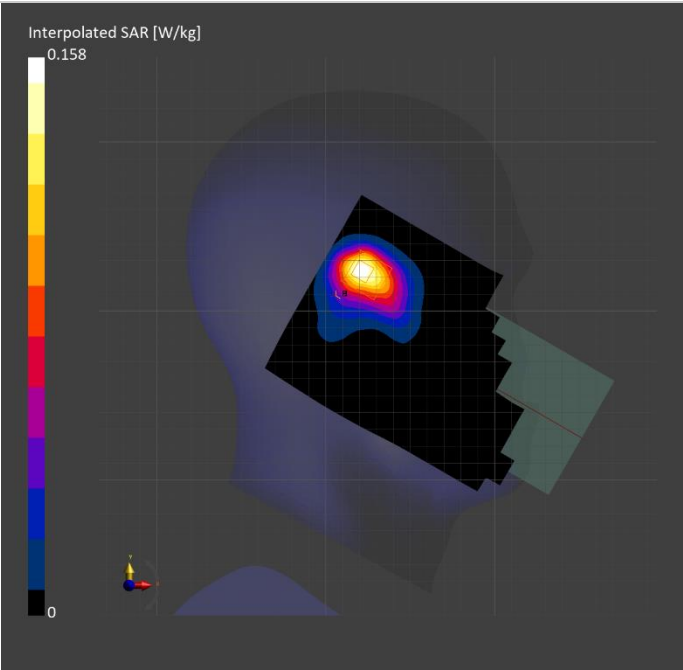
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL2450-2025-04-30 | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 200.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 10.0 x 10.0   | 5.0 x 5.0 x 1.5    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.5                |
| MAIA                | Y             | Y                  |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-30    | 2025-04-30    |
| psSAR1g [W/kg]      | 0.121         | 0.123         |
| psSAR10g [W/kg]     | 0.060         | 0.062         |
| Power Drift [dB]    | 0.07          | 0.01          |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 82.2          |
| Dist 3dB Peak [mm]  |               | 11.2          |



P17 GSM850\_GPRS 1Tx Slot\_Rear Face\_1.5cm\_Ch251

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band    | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|---------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | BACK, 15.00                  | GSM 850 | GSM, -     | 848.800, 251                    | 9.75              | 0.926                  | 43.4             |

Hardware Setup

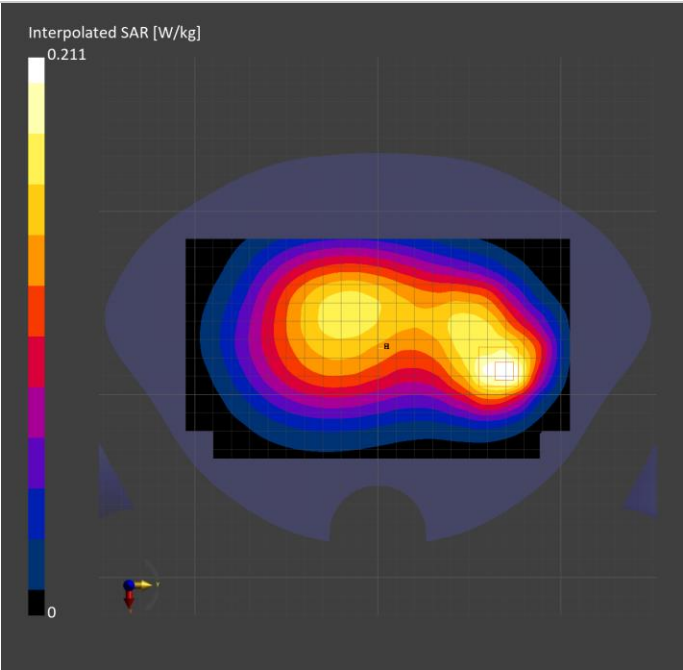
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL835-2025-04-21  | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 210.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 15.0 x 15.0   | 6.0 x 6.0 x 1.5    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.5                |
| MAIA                | N/A           | N/A                |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-21    | 2025-04-21    |
| psSAR1g [W/kg]      | 0.181         | 0.178         |
| psSAR10g [W/kg]     | 0.120         | 0.109         |
| Power Drift [dB]    | -0.01         | -0.01         |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 83.0          |
| Dist 3dB Peak [mm]  |               | 14.0          |



P18 GSM1900\_GPRS 1Tx Slot\_Rear Face\_1.5cm\_Ch661

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band     | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|----------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | BACK, 15.00                  | PCS 1900 | GSM, -     | 1880.000, 661                   | 8.25              | 1.38                   | 40.8             |

Hardware Setup

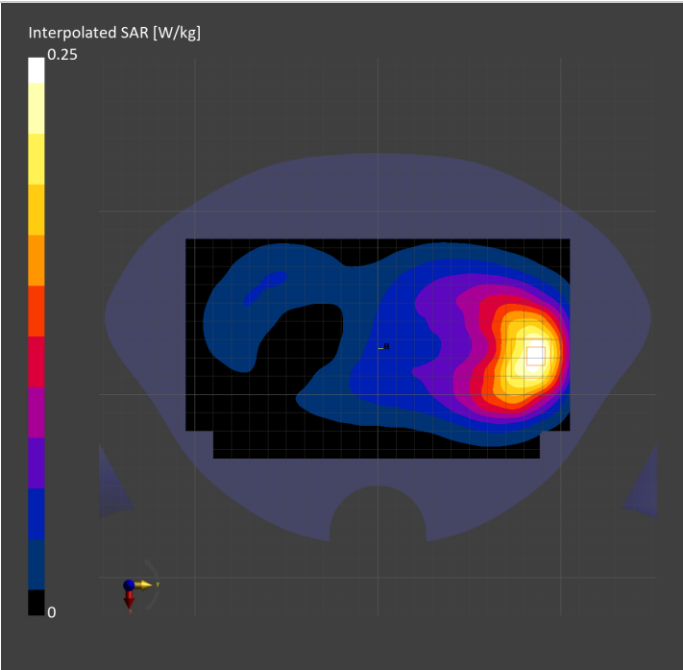
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL1950-2025-04-22 | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 210.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 15.0 x 15.0   | 6.0 x 6.0 x 1.5    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.5                |
| MAIA                | N/A           | N/A                |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-22    | 2025-04-22    |
| psSAR1g [W/kg]      | 0.204         | 0.219         |
| psSAR10g [W/kg]     | 0.122         | 0.129         |
| Power Drift [dB]    | -0.02         | 0.00          |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 85.0          |
| Dist 3dB Peak [mm]  |               | 14.1          |



P19 WCDMA II\_RMC12.2K\_Rear Face\_1.5cm\_Ch9262

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band   | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|--------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | BACK, 15.00                  | Band 2 | WCDMA, -   | 1852.400, 9262                  | 8.25              | 1.37                   | 40.9             |

Hardware Setup

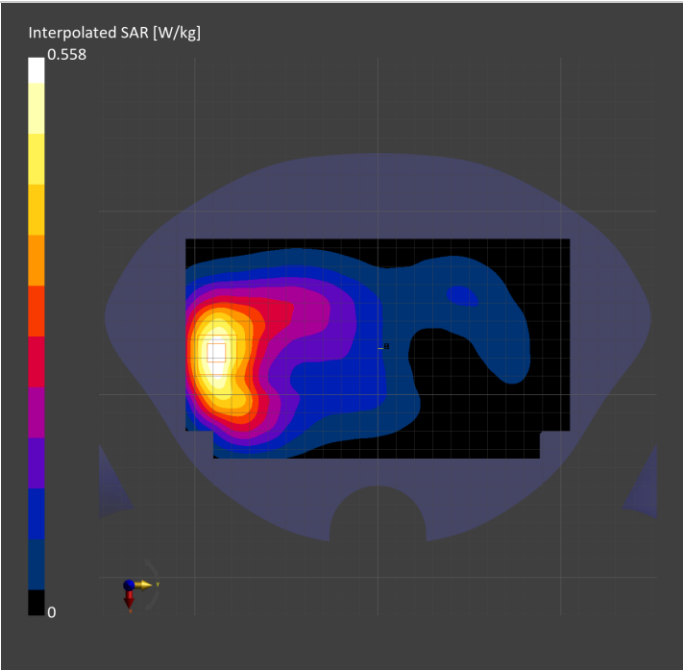
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL1950-2025-04-22 | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 210.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 15.0 x 15.0   | 6.0 x 6.0 x 1.5    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.5                |
| MAIA                | N/A           | N/A                |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-22    | 2025-04-22    |
| psSAR1g [W/kg]      | 0.459         | 0.467         |
| psSAR10g [W/kg]     | 0.274         | 0.285         |
| Power Drift [dB]    | -0.00         | -0.03         |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 85.3          |
| Dist 3dB Peak [mm]  |               | 16.8          |



P20 WCDMA IV\_RMC12.2K\_Rear Face\_1.5cm\_Ch1312

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band   | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|--------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | BACK, 15.00                  | Band 4 | WCDMA, -   | 1712.400, 1312                  | 8.6               | 1.32                   | 41.5             |

Hardware Setup

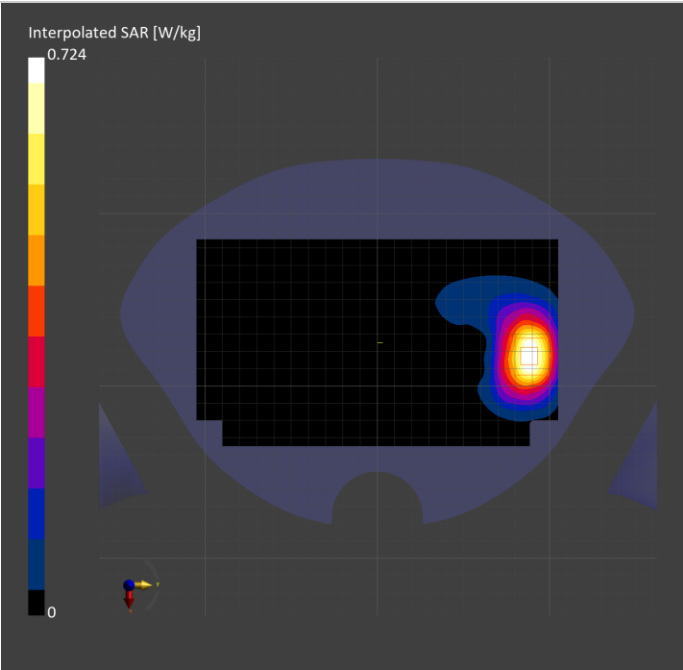
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL1750-2025-04-23 | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 210.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 15.0 x 15.0   | 6.0 x 6.0 x 1.5    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.5                |
| MAIA                | N/A           | N/A                |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-23    | 2025-04-23    |
| psSAR1g [W/kg]      | 0.602         | 0.649         |
| psSAR10g [W/kg]     | 0.344         | 0.363         |
| Power Drift [dB]    | -0.00         | -0.01         |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 85.3          |
| Dist 3dB Peak [mm]  |               | 12.0          |



P21 WCDMA V\_RMC12.2K\_Rear Face\_1.5cm\_Ch4132

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band   | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|--------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | BACK, 15.00                  | Band 5 | WCDMA, -   | 826,400, 4132                   | 9.75              | 0.916                  | 43.4             |

Hardware Setup

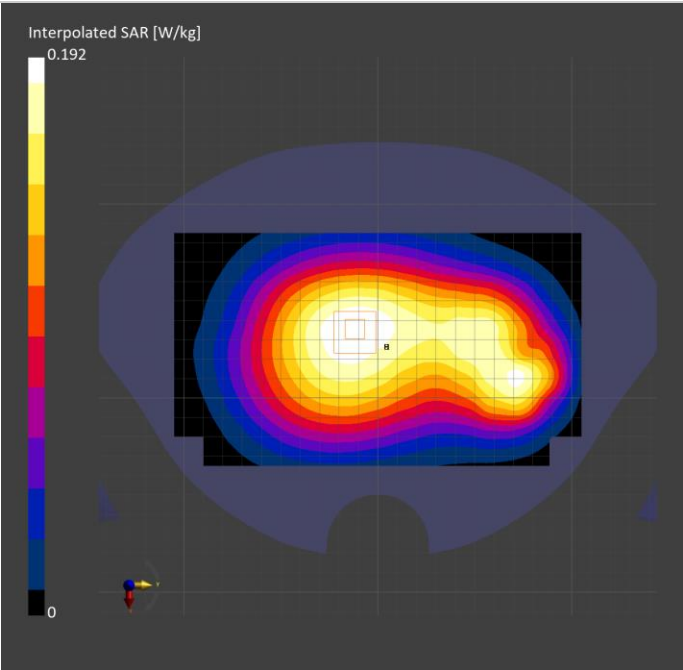
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL835-2025-04-21  | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 210.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 15.0 x 15.0   | 6.0 x 6.0 x 1.5    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.5                |
| MAIA                | N/A           | N/A                |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-21    | 2025-04-21    |
| psSAR1g [W/kg]      | 0.169         | 0.179         |
| psSAR10g [W/kg]     | 0.119         | 0.135         |
| Power Drift [dB]    | 0.01          | -0.03         |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 90.3          |
| Dist 3dB Peak [mm]  |               | > 15.0        |



P22 LTE B2\_QPSK20M\_Rear Face\_1.5cm\_Ch18900\_1RB\_OS50

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band   | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|--------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | BACK, 15.00                  | Band 2 | LTE-FDD, - | 1880.000, 18900                 | 8.25              | 1.38                   | 40.8             |

Hardware Setup

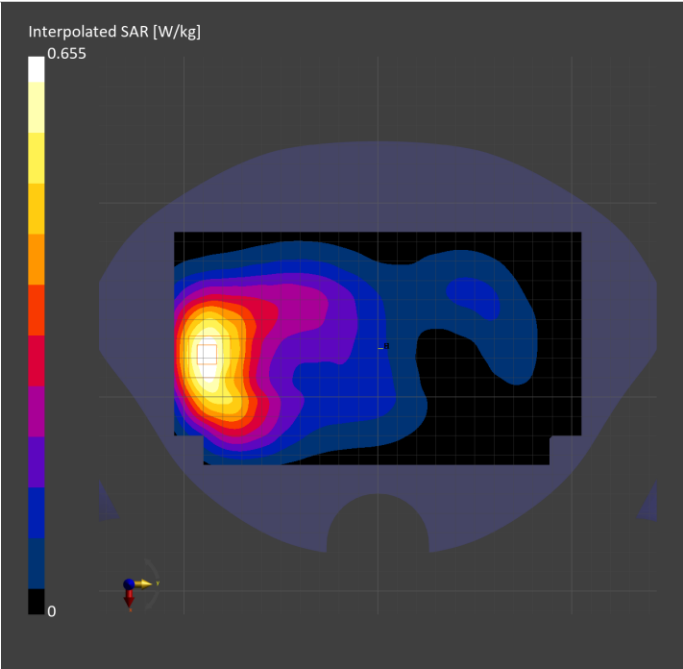
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL1950-2025-04-22 | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 210.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 15.0 x 15.0   | 6.0 x 6.0 x 1.5    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.5                |
| MAIA                | N/A           | N/A                |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-22    | 2025-04-22    |
| psSAR1g [W/kg]      | 0.540         | 0.551         |
| psSAR10g [W/kg]     | 0.322         | 0.336         |
| Power Drift [dB]    | 0.00          | -0.01         |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 85.7          |
| Dist 3dB Peak [mm]  |               | 16.1          |



P23 LTE B7\_QPSK20M\_Rear Face\_1.5cm\_Ch20850\_1RB\_OS50

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band   | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|--------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | BACK, 15.00                  | Band 7 | LTE-FDD, - | 2510.000, 20850                 | 7.57              | 1.89                   | 37.8             |

Hardware Setup

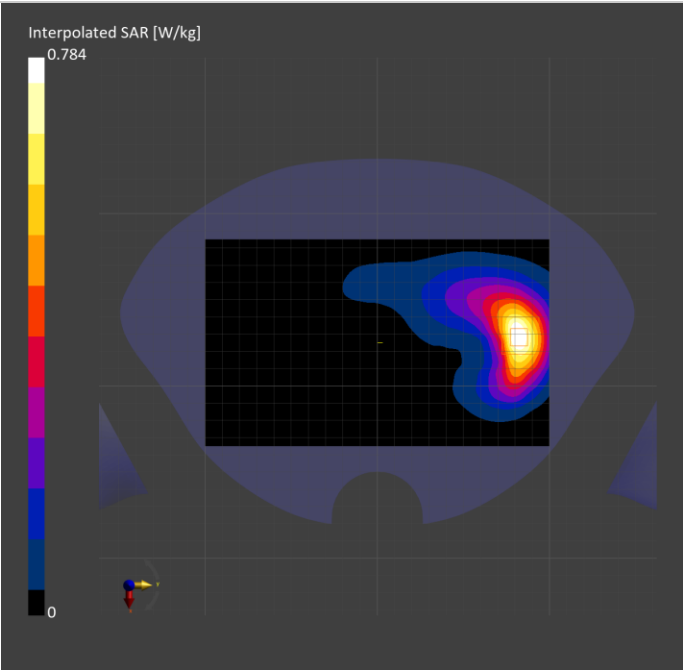
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL2550-2025-04-24 | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 200.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 10.0 x 10.0   | 5.0 x 5.0 x 1.5    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.5                |
| MAIA                | N/A           | N/A                |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-24    | 2025-04-24    |
| psSAR1g [W/kg]      | 0.626         | 0.626         |
| psSAR10g [W/kg]     | 0.323         | 0.322         |
| Power Drift [dB]    | -0.07         | 0.00          |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 83.3          |
| Dist 3dB Peak [mm]  |               | 11.5          |



P24 LTE B13\_QPSK10M\_Rear Face\_1.5cm\_Ch23230\_1RB\_OS24

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band    | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|---------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | BACK, 15.00                  | Band 13 | LTE-FDD, - | 782.000, 23230                  | 10.21             | 0.898                  | 43.6             |

Hardware Setup

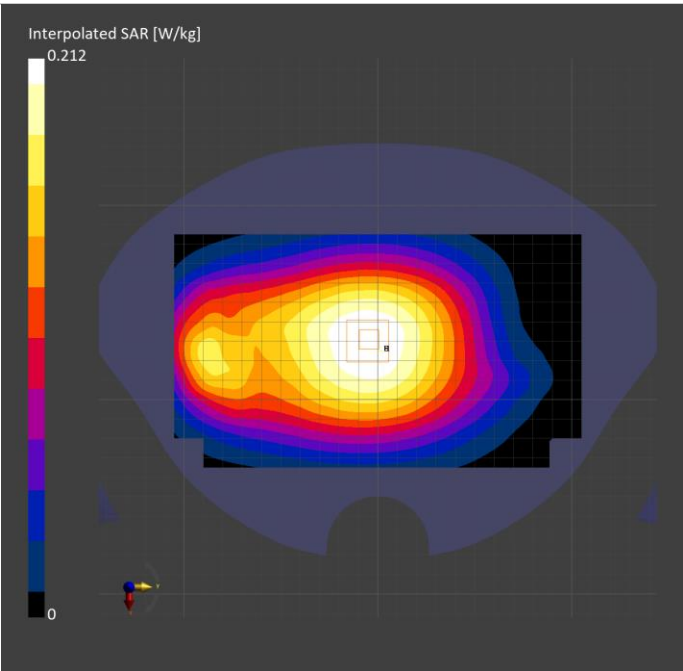
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL750-2025-04-25  | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 210.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 15.0 x 15.0   | 6.0 x 6.0 x 1.5    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.5                |
| MAIA                | N/A           | N/A                |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-25    | 2025-04-25    |
| psSAR1g [W/kg]      | 0.188         | 0.201         |
| psSAR10g [W/kg]     | 0.134         | 0.153         |
| Power Drift [dB]    | -0.00         | -0.06         |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 89.8          |
| Dist 3dB Peak [mm]  |               | > 15.0        |



P25 LTE B26\_QPSK15M\_Rear Face\_1.5cm\_Ch26965\_1RB\_OS37

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band    | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|---------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | BACK, 15.00                  | Band 26 | LTE-FDD, - | 841.500, 26965                  | 9.75              | 0.923                  | 43.4             |

Hardware Setup

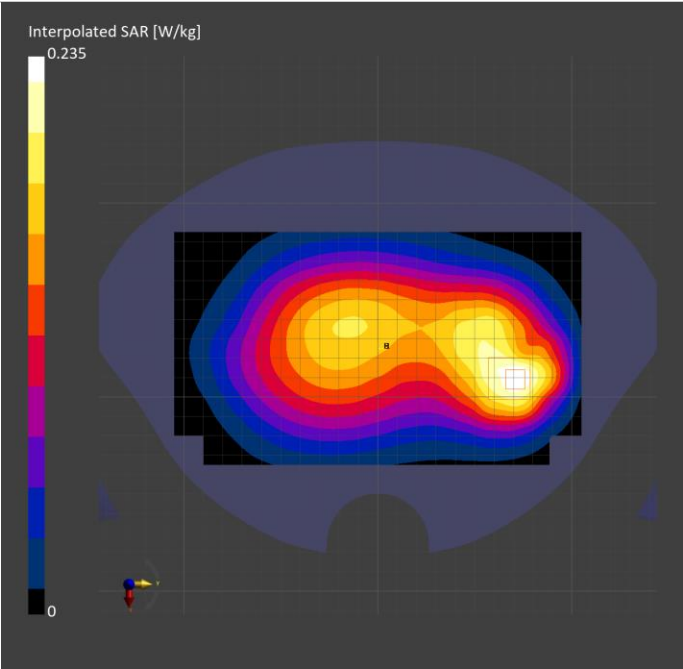
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL835-2025-04-21  | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 210.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 15.0 x 15.0   | 6.0 x 6.0 x 1.5    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.5                |
| MAIA                | N/A           | N/A                |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-21    | 2025-04-21    |
| psSAR1g [W/kg]      | 0.202         | 0.201         |
| psSAR10g [W/kg]     | 0.135         | 0.124         |
| Power Drift [dB]    | 0.03          | -0.03         |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 80.6          |
| Dist 3dB Peak [mm]  |               | 14.0          |



P26 LTE B41\_QPSK20M\_Rear Face\_1.5cm\_Ch40620\_1RB\_OS50

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band    | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|---------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | BACK, 15.00                  | Band 41 | LTE-TDD, - | 2593.000, 40620                 | 7.57              | 1.94                   | 37.7             |

Hardware Setup

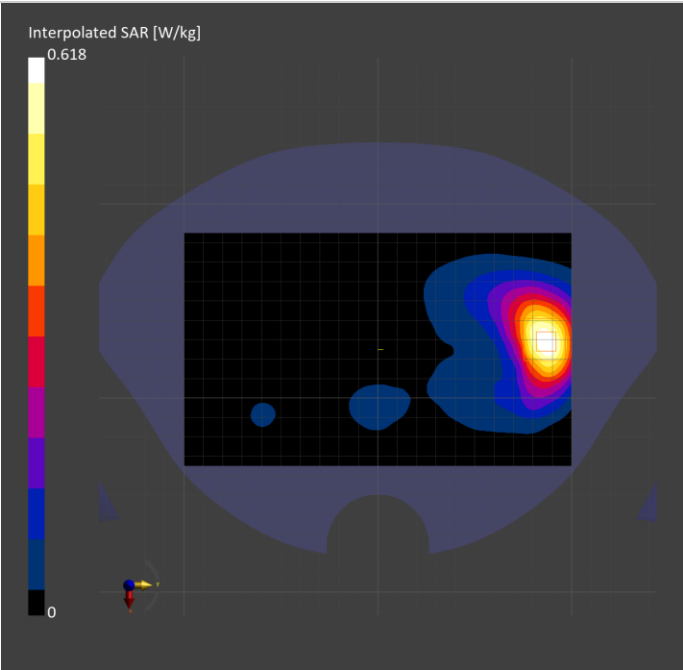
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL2550-2025-04-24 | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 200.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 10.0 x 10.0   | 5.0 x 5.0 x 1.5    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.5                |
| MAIA                | N/A           | N/A                |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-24    | 2025-04-24    |
| psSAR1g [W/kg]      | 0.492         | 0.498         |
| psSAR10g [W/kg]     | 0.257         | 0.259         |
| Power Drift [dB]    | -0.02         | -0.02         |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 81.5          |
| Dist 3dB Peak [mm]  |               | 12.7          |



P27 LTE B66\_QPSK20M\_Rear Face\_1.5cm\_Ch132072\_1RB\_OS50

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band    | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|---------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | BACK, 15.00                  | Band 66 | LTE-FDD, - | 1720.000, 132072                | 8.6               | 1.32                   | 41.5             |

Hardware Setup

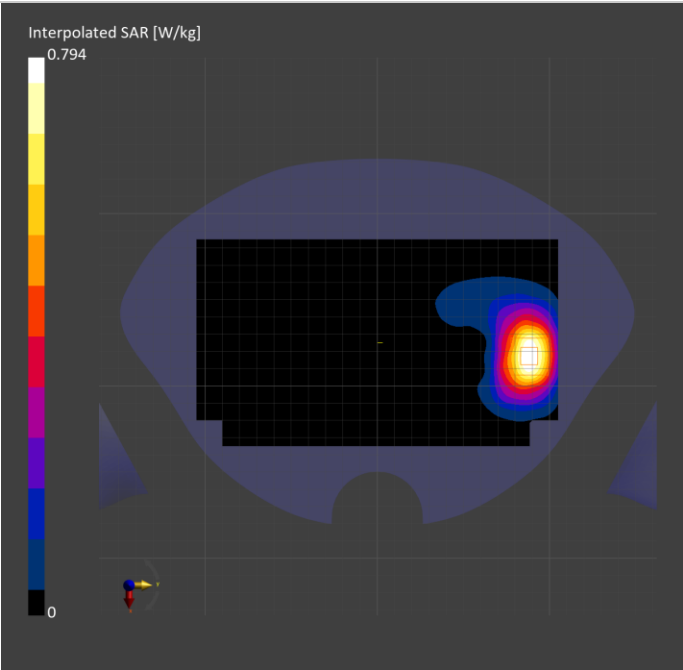
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL1750-2025-04-23 | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 210.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 15.0 x 15.0   | 6.0 x 6.0 x 1.5    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.5                |
| MAIA                | N/A           | N/A                |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-23    | 2025-04-23    |
| psSAR1g [W/kg]      | 0.662         | 0.730         |
| psSAR10g [W/kg]     | 0.378         | 0.407         |
| Power Drift [dB]    | 0.01          | 0.01          |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 84.9          |
| Dist 3dB Peak [mm]  |               | 11.9          |



P28 WLAN 2.4G\_802.11b\_Rear Face\_1.5cm\_Ch1

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band        | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|-------------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | BACK, 15.00                  | WLAN 2.4GHz | WLAN, -    | 2412.000, 1                     | 7.7               | 1.81                   | 38.0             |

Hardware Setup

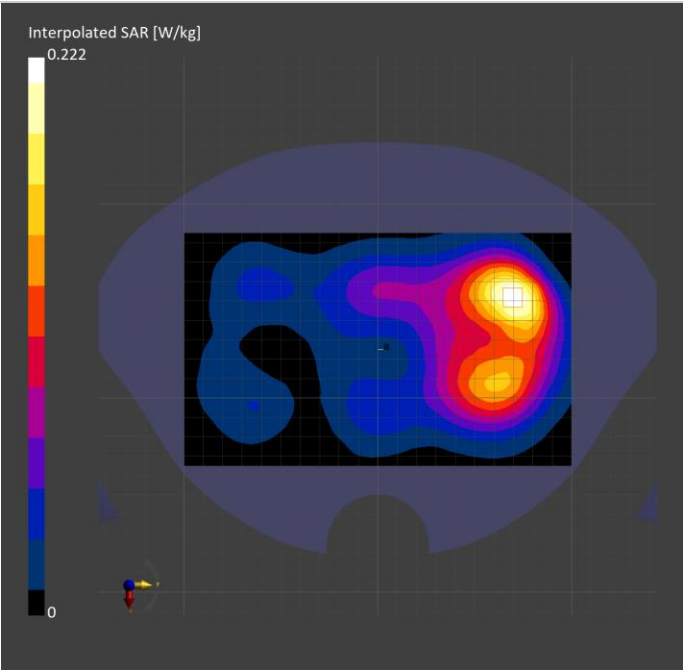
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL2450-2025-04-30 | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 200.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 10.0 x 10.0   | 5.0 x 5.0 x 1.5    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.5                |
| MAIA                | Y             | N/A                |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-30    | 2025-04-30    |
| psSAR1g [W/kg]      | 0.178         | 0.179         |
| psSAR10g [W/kg]     | 0.097         | 0.097         |
| Power Drift [dB]    | -0.03         | -0.01         |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 80.4          |
| Dist 3dB Peak [mm]  |               | 14.2          |



P29 WLAN 5G\_802.11a\_Rear Face\_1.5cm\_Ch60

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band      | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|-----------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | BACK, 15.00                  | WLAN 5GHz | WLAN, -    | 5300.000, 60                    | 4.99              | 4.65                   | 36.2             |

Hardware Setup

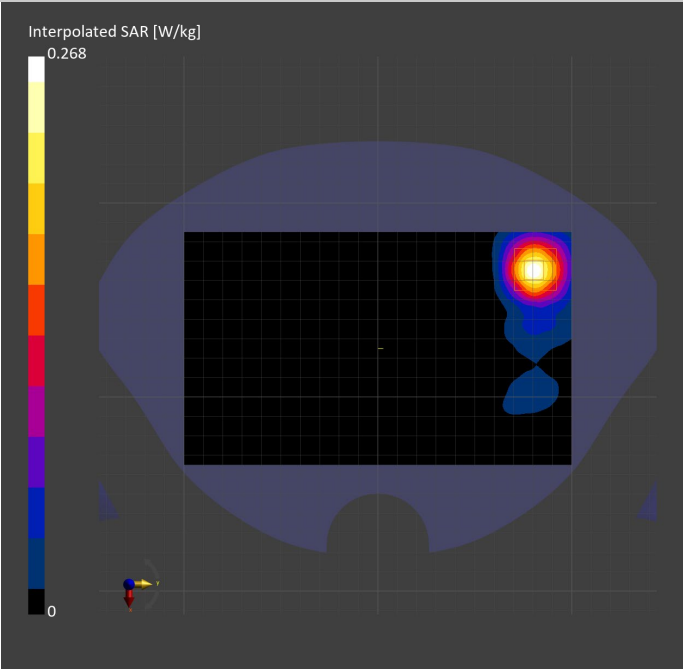
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL5G-2025-04-29   | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 200.0 | 22.0 x 22.0 x 22.0 |
| Grid Steps [mm]     | 10.0 x 10.0   | 4.0 x 4.0 x 1.4    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.4                |
| MAIA                | Y             | Y                  |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-29    | 2025-04-29    |
| psSAR1g [W/kg]      | 0.206         | 0.227         |
| psSAR10g [W/kg]     | 0.077         | 0.084         |
| Power Drift [dB]    | -0.01         | -0.09         |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 64.0          |
| Dist 3dB Peak [mm]  |               | 10.9          |



P30 WLAN5G\_802.11a\_Rear Face\_1.5cm\_Ch100

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band      | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|-----------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | BACK, 15.00                  | WLAN 5GHz | WLAN, -    | 5500.000, 100                   | 4.65              | 4.88                   | 35.8             |

Hardware Setup

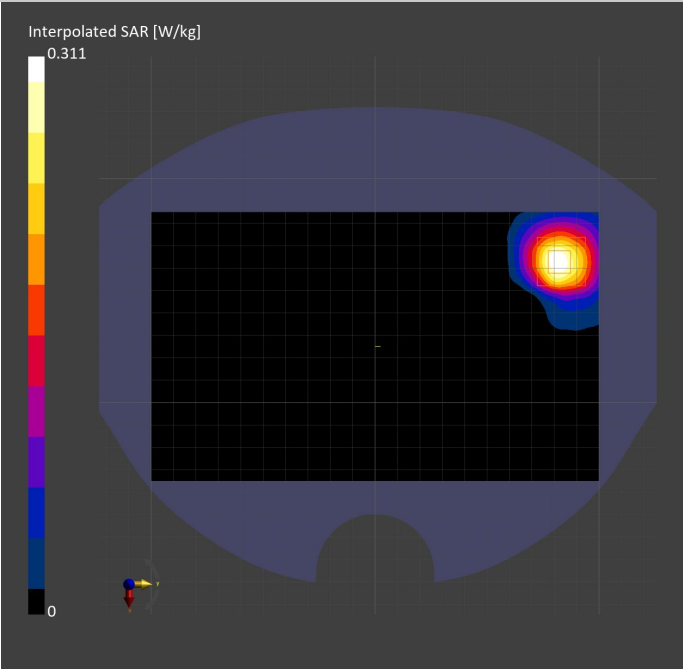
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL5G-2025-04-29   | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 200.0 | 22.0 x 22.0 x 22.0 |
| Grid Steps [mm]     | 10.0 x 10.0   | 4.0 x 4.0 x 1.4    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.4                |
| MAIA                | Y             | Y                  |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-29    | 2025-04-29    |
| psSAR1g [W/kg]      | 0.228         | 0.232         |
| psSAR10g [W/kg]     | 0.088         | 0.084         |
| Power Drift [dB]    | -0.62         | 0.03          |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 67.0          |
| Dist 3dB Peak [mm]  |               | 9.0           |



P31 WLAN5G\_802.11a\_Rear Face\_1.5cm\_Ch149

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band      | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|-----------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | BACK, 15.00                  | WLAN 5GHz | WLAN, -    | 5745.000, 149                   | 4.76              | 5.17                   | 35.4             |

Hardware Setup

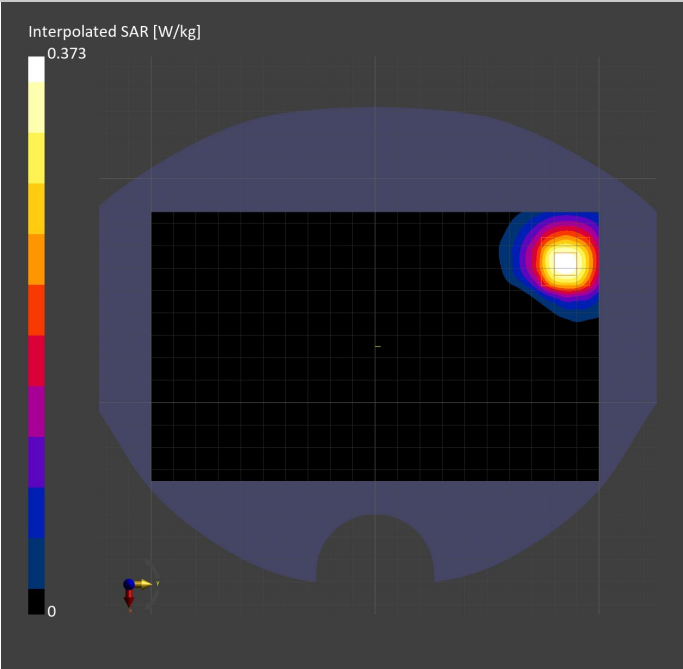
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL5G-2025-04-30   | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 200.0 | 22.0 x 22.0 x 22.0 |
| Grid Steps [mm]     | 10.0 x 10.0   | 4.0 x 4.0 x 1.4    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.4                |
| MAIA                | Y             | Y                  |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-30    | 2025-04-30    |
| psSAR1g [W/kg]      | 0.283         | 0.289         |
| psSAR10g [W/kg]     | 0.110         | 0.107         |
| Power Drift [dB]    | -0.09         | -0.09         |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 64.5          |
| Dist 3dB Peak [mm]  |               | 10.2          |



P32 BT\_GFSK\_Rear Face\_1.5cm\_Ch39

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band             | Group, UID   | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|------------------|--------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | BACK, 15.00                  | ISM 2.4 GHz Band | Bluetooth, - | 2441.000, 39                    | 7.7               | 1.83                   | 37.9             |

Hardware Setup

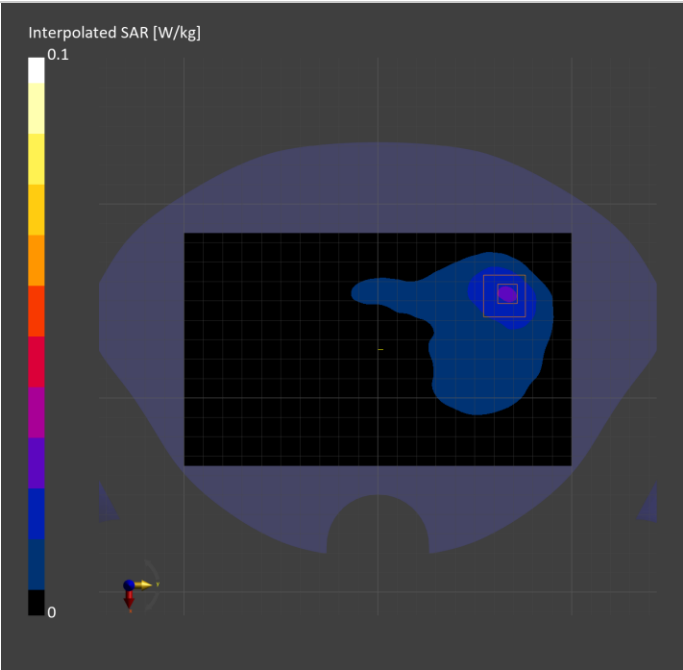
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL2450-2025-04-30 | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 200.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 10.0 x 10.0   | 5.0 x 5.0 x 1.5    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.5                |
| MAIA                | Y             | Y                  |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-30    | 2025-04-30    |
| psSAR1g [W/kg]      | 0.021         | 0.021         |
| psSAR10g [W/kg]     | 0.011         | 0.011         |
| Power Drift [dB]    | -0.18         | -0.04         |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 79.9          |
| Dist 3dB Peak [mm]  |               | 14.3          |



P33 GSM850\_GPRS 1Tx Slot\_Rear Face\_1cm\_Ch251

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band    | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|---------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | BACK, 10.00                  | GSM 850 | GSM, -     | 848.800, 251                    | 9.75              | 0.925                  | 43.4             |

Hardware Setup

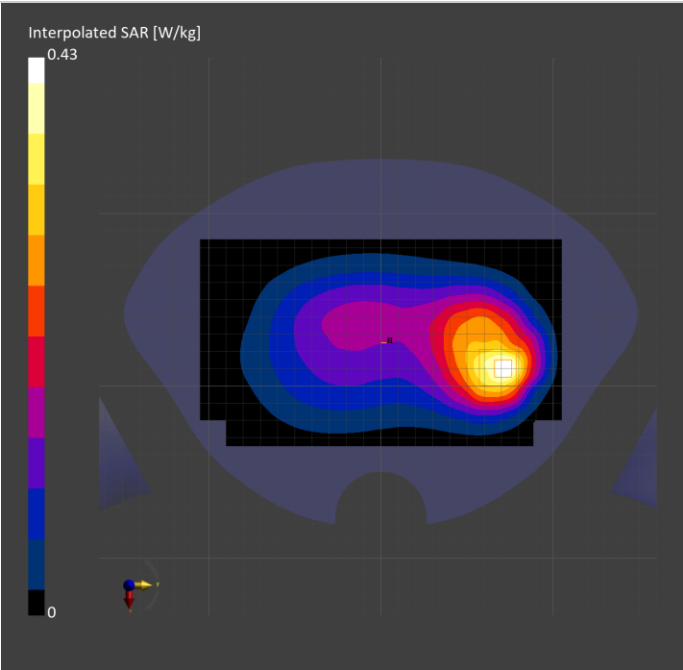
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL835-2025-04-21  | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 210.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 15.0 x 15.0   | 6.0 x 6.0 x 1.5    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.5                |
| MAIA                | N/A           | N/A                |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-21    | 2025-04-21    |
| psSAR1g [W/kg]      | 0.361         | 0.351         |
| psSAR10g [W/kg]     | 0.231         | 0.203         |
| Power Drift [dB]    | 0.00          | 0.00          |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 79.7          |
| Dist 3dB Peak [mm]  |               | 10.2          |



P34 GSM1900\_GPRS 1Tx Slot\_Top Side\_1cm\_Ch661

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band     | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|----------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | EDGE Top, 10.00              | PCS 1900 | GSM, -     | 1880.000, 661                   | 8.25              | 1.38                   | 40.8             |

Hardware Setup

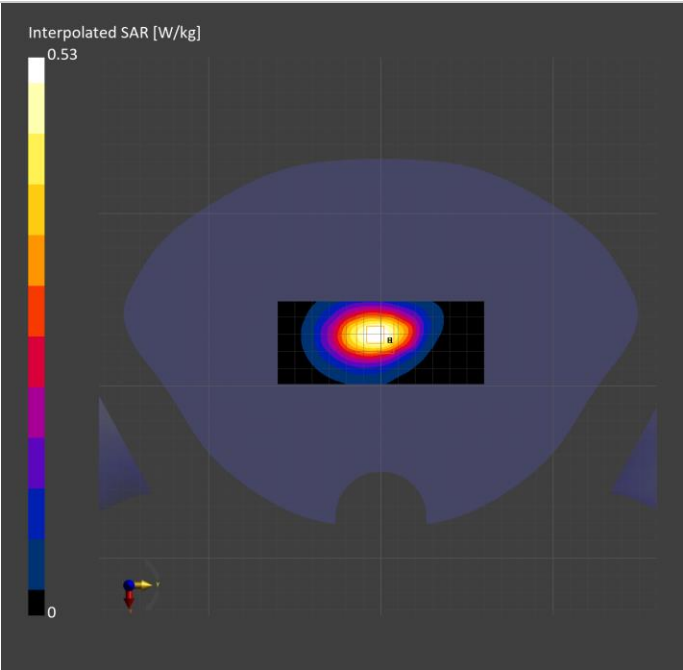
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL1950-2025-04-22 | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan    | Zoom Scan          |
|---------------------|--------------|--------------------|
| Grid Extents [mm]   | 48.0 x 120.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 8.0 x 15.0   | 6.0 x 6.0 x 1.5    |
| Sensor Surface [mm] | 3.0          | 1.4                |
| Graded Grid         | N/A          | Yes                |
| Grading Ratio       | N/A          | 1.5                |
| MAIA                | N/A          | N/A                |
| Surface Detection   | VMS + 6p     | VMS + 6p           |
| Scan Method         | Measured     | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-22    | 2025-04-22    |
| psSAR1g [W/kg]      | 0.432         | 0.442         |
| psSAR10g [W/kg]     | 0.236         | 0.247         |
| Power Drift [dB]    | -0.00         | 0.02          |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 84.6          |
| Dist 3dB Peak [mm]  |               | 12.0          |



P35 WCDMA II\_RMC12.2K\_Bottom Side\_1cm\_Ch9262

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band   | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|--------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | EDGE BOTTOM, 10.00           | Band 2 | WCDMA, -   | 1852.400, 9262                  | 8.25              | 1.36                   | 40.9             |

Hardware Setup

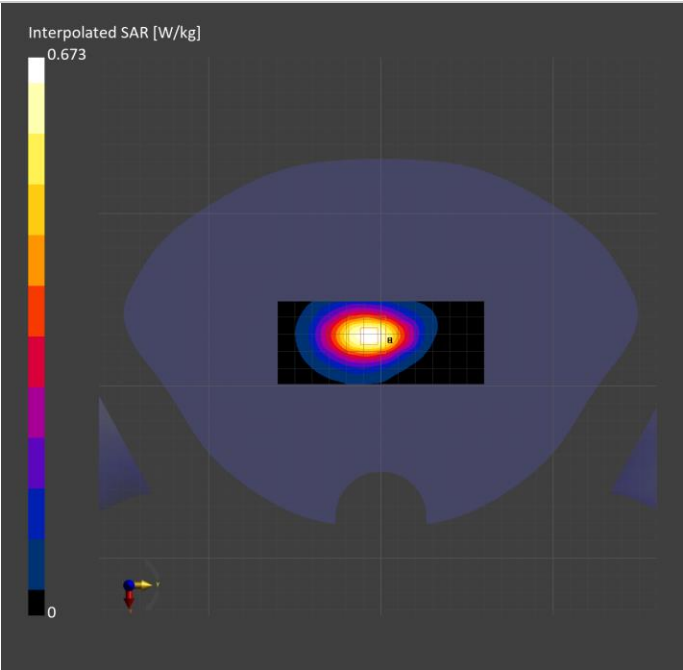
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL1950-2025-04-22 | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan    | Zoom Scan          |
|---------------------|--------------|--------------------|
| Grid Extents [mm]   | 48.0 x 120.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 8.0 x 15.0   | 6.0 x 6.0 x 1.5    |
| Sensor Surface [mm] | 3.0          | 1.4                |
| Graded Grid         | N/A          | Yes                |
| Grading Ratio       | N/A          | 1.5                |
| MAIA                | N/A          | N/A                |
| Surface Detection   | VMS + 6p     | VMS + 6p           |
| Scan Method         | Measured     | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-22    | 2025-04-22    |
| psSAR1g [W/kg]      | 0.546         | 0.556         |
| psSAR10g [W/kg]     | 0.297         | 0.308         |
| Power Drift [dB]    | 0.01          | -0.01         |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 84.0          |
| Dist 3dB Peak [mm]  |               | 11.9          |



P36 WCDMA IV\_RMC12.2K\_Bottom Side\_1cm\_Ch1513

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band   | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|--------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | EDGE BOTTOM, 10.00           | Band 4 | WCDMA, -   | 1752.600, 1513                  | 8.6               | 1.34                   | 41.4             |

Hardware Setup

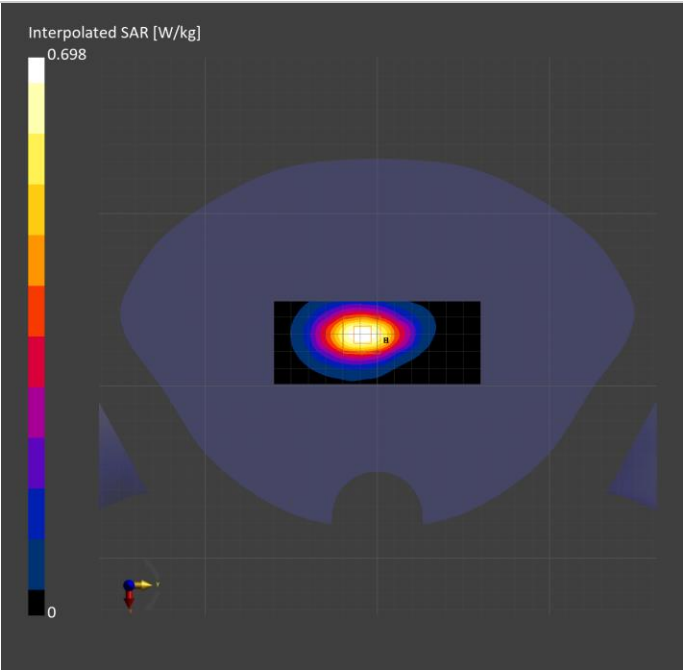
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL1750-2025-04-23 | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan    | Zoom Scan          |
|---------------------|--------------|--------------------|
| Grid Extents [mm]   | 48.0 x 120.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 8.0 x 15.0   | 6.0 x 6.0 x 1.5    |
| Sensor Surface [mm] | 3.0          | 1.4                |
| Graded Grid         | N/A          | Yes                |
| Grading Ratio       | N/A          | 1.5                |
| MAIA                | N/A          | N/A                |
| Surface Detection   | VMS + 6p     | VMS + 6p           |
| Scan Method         | Measured     | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-23    | 2025-04-23    |
| psSAR1g [W/kg]      | 0.568         | 0.582         |
| psSAR10g [W/kg]     | 0.311         | 0.323         |
| Power Drift [dB]    | -0.00         | 0.01          |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 84.7          |
| Dist 3dB Peak [mm]  |               | 11.1          |



P37 WCDMA V\_RMC12.2K\_Rear Face\_1cm\_Ch4233

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band   | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|--------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | BACK, 10.00                  | Band 5 | WCDMA, -   | 846.600, 4233                   | 9.75              | 0.916                  | 43.4             |

Hardware Setup

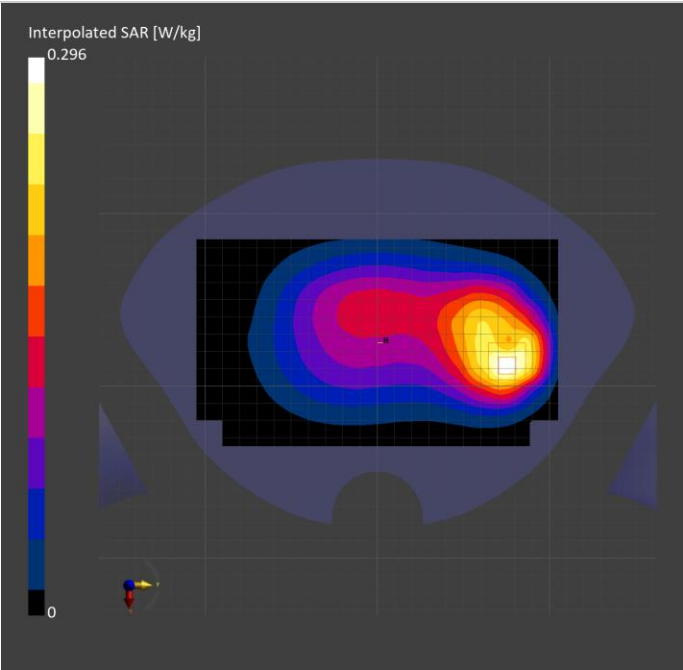
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL835-2025-04-21  | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 210.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 15.0 x 15.0   | 6.0 x 6.0 x 1.5    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.5                |
| MAIA                | N/A           | N/A                |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-21    | 2025-04-21    |
| psSAR1g [W/kg]      | 0.249         | 0.251         |
| psSAR10g [W/kg]     | 0.162         | 0.147         |
| Power Drift [dB]    | 0.00          | 0.00          |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 75.8          |
| Dist 3dB Peak [mm]  |               | 10.8          |



P38 LTE B2\_QPSK20M\_Bottom Side\_1cm\_Ch18700\_1RB\_OS50

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band   | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|--------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | EDGE BOTTOM, 10.00           | Band 2 | LTE-FDD, - | 1860.000, 18700                 | 8.25              | 1.37                   | 40.8             |

Hardware Setup

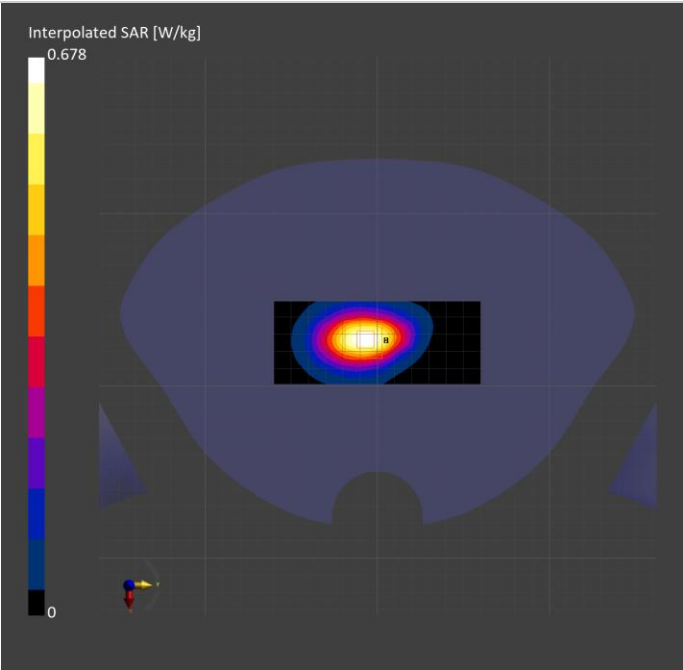
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL1950-2025-04-22 | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan    | Zoom Scan          |
|---------------------|--------------|--------------------|
| Grid Extents [mm]   | 48.0 x 120.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 8.0 x 15.0   | 6.0 x 6.0 x 1.5    |
| Sensor Surface [mm] | 3.0          | 1.4                |
| Graded Grid         | N/A          | Yes                |
| Grading Ratio       | N/A          | 1.5                |
| MAIA                | N/A          | N/A                |
| Surface Detection   | VMS + 6p     | VMS + 6p           |
| Scan Method         | Measured     | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-22    | 2025-04-22    |
| psSAR1g [W/kg]      | 0.548         | 0.559         |
| psSAR10g [W/kg]     | 0.298         | 0.310         |
| Power Drift [dB]    | 0.01          | -0.00         |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 84.3          |
| Dist 3dB Peak [mm]  |               | 11.9          |



P39 LTE B7\_QPSK20M\_Bottom Side\_1cm\_Ch21350\_1RB\_OS50

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band   | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|--------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | EDGE BOTTOM, 10.00           | Band 7 | LTE-FDD, - | 2560.000, 21350                 | 7.57              | 1.90                   | 37.8             |

Hardware Setup

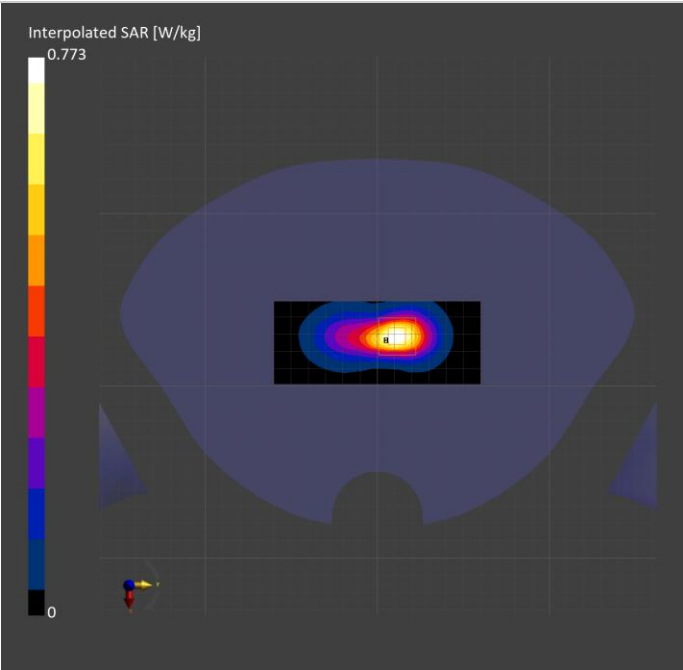
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL2550-2025-04-24 | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan    | Zoom Scan          |
|---------------------|--------------|--------------------|
| Grid Extents [mm]   | 48.0 x 120.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 8.0 x 10.0   | 5.0 x 5.0 x 1.5    |
| Sensor Surface [mm] | 3.0          | 1.4                |
| Graded Grid         | N/A          | Yes                |
| Grading Ratio       | N/A          | 1.5                |
| MAIA                | N/A          | N/A                |
| Surface Detection   | VMS + 6p     | VMS + 6p           |
| Scan Method         | Measured     | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-24    | 2025-04-24    |
| psSAR1g [W/kg]      | 0.591         | 0.604         |
| psSAR10g [W/kg]     | 0.273         | 0.277         |
| Power Drift [dB]    | -0.01         | -0.01         |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 80.0          |
| Dist 3dB Peak [mm]  |               | 9.0           |



P40 LTE B13\_QPSK10M\_Rear Face\_1cm\_Ch23230\_1RB\_OS24

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band    | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|---------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | BACK, 10.00                  | Band 13 | LTE-FDD, - | 782.000, 23230                  | 10.21             | 0.897                  | 43.6             |

Hardware Setup

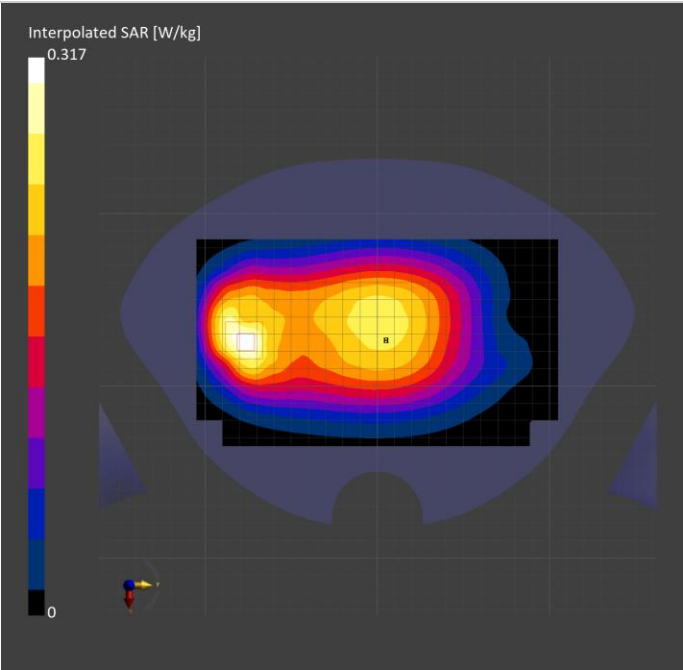
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL750-2025-04-25  | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 210.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 15.0 x 15.0   | 6.0 x 6.0 x 1.5    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.5                |
| MAIA                | N/A           | N/A                |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-25    | 2025-04-25    |
| psSAR1g [W/kg]      | 0.271         | 0.278         |
| psSAR10g [W/kg]     | 0.179         | 0.163         |
| Power Drift [dB]    | -0.01         | -0.01         |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 79.1          |
| Dist 3dB Peak [mm]  |               | 12.8          |



P41 LTE B26\_QPSK15M\_Rear Face\_1cm\_Ch26956\_1RB\_OS37

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band    | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|---------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | BACK, 10.00                  | Band 26 | LTE-FDD, - | 841.500, 26965                  | 9.75              | 0.92                   | 43.4             |

Hardware Setup

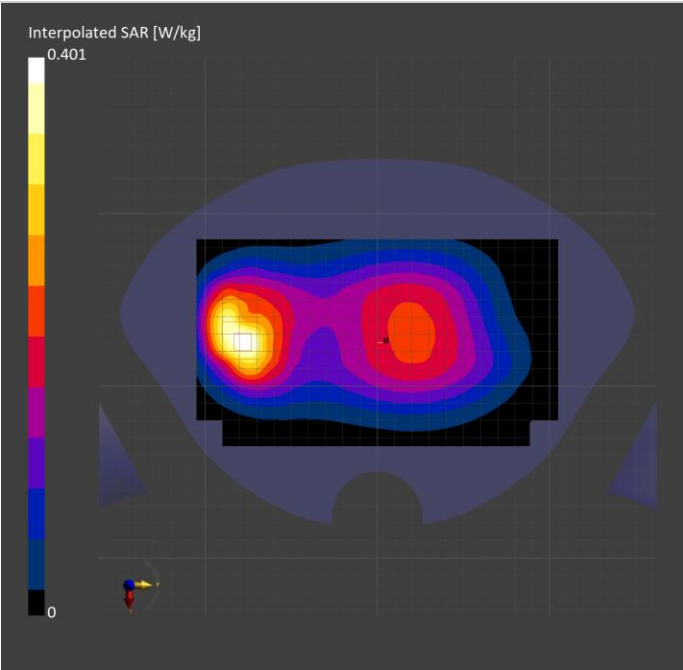
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL835-2025-04-21  | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 210.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 15.0 x 15.0   | 6.0 x 6.0 x 1.5    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.5                |
| MAIA                | N/A           | N/A                |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-21    | 2025-04-21    |
| psSAR1g [W/kg]      | 0.342         | 0.356         |
| psSAR10g [W/kg]     | 0.221         | 0.205         |
| Power Drift [dB]    | -0.00         | -0.00         |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 78.8          |
| Dist 3dB Peak [mm]  |               | 12.4          |



P42 LTE B41\_QPSK20M\_Bottom Side\_1cm\_Ch40620\_1RB\_OS50

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band    | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|---------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | EDGE BOTTOM, 10.00           | Band 41 | LTE-TDD, - | 2593.000, 40620                 | 7.57              | 1.94                   | 37.7             |

Hardware Setup

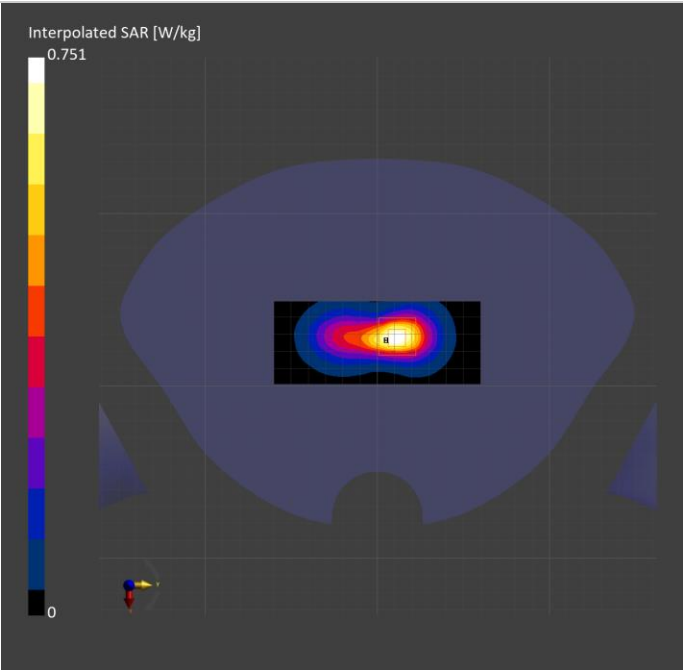
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL2550-2025-04-24 | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan    | Zoom Scan          |
|---------------------|--------------|--------------------|
| Grid Extents [mm]   | 48.0 x 120.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 8.0 x 10.0   | 5.0 x 5.0 x 1.5    |
| Sensor Surface [mm] | 3.0          | 1.4                |
| Graded Grid         | N/A          | Yes                |
| Grading Ratio       | N/A          | 1.5                |
| MAIA                | N/A          | N/A                |
| Surface Detection   | VMS + 6p     | VMS + 6p           |
| Scan Method         | Measured     | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-24    | 2025-04-24    |
| psSAR1g [W/kg]      | 0.573         | 0.588         |
| psSAR10g [W/kg]     | 0.267         | 0.272         |
| Power Drift [dB]    | -0.01         | 0.01          |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 79.2          |
| Dist 3dB Peak [mm]  |               | 9.0           |



P43 LTE B66\_QPSK20M\_Bottom Side\_1cm\_Ch132572\_1RB\_OS50

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band    | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|---------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | EDGE BOTTOM, 10.00           | Band 66 | LTE-FDD, - | 1770.000, 132572                | 8.6               | 1.34                   | 41.5             |

Hardware Setup

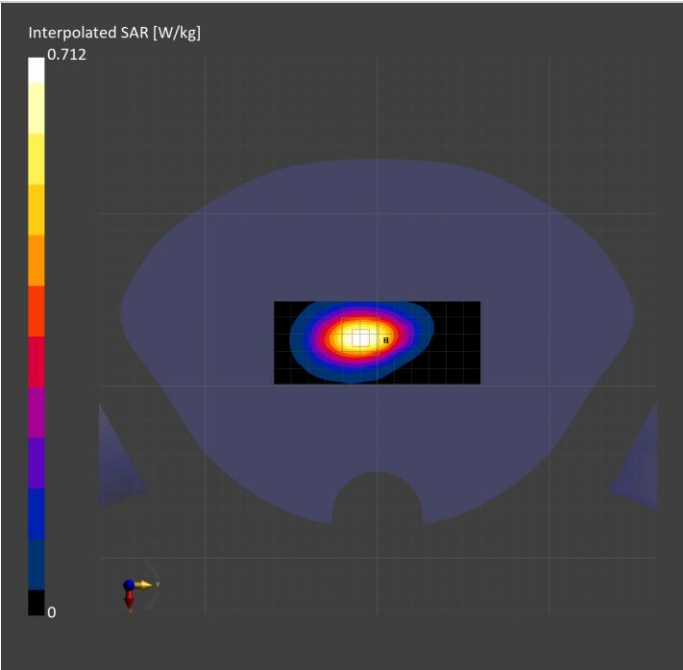
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL1750-2025-04-23 | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan    | Zoom Scan          |
|---------------------|--------------|--------------------|
| Grid Extents [mm]   | 48.0 x 120.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 8.0 x 15.0   | 6.0 x 6.0 x 1.5    |
| Sensor Surface [mm] | 3.0          | 1.4                |
| Graded Grid         | N/A          | Yes                |
| Grading Ratio       | N/A          | 1.5                |
| MAIA                | N/A          | N/A                |
| Surface Detection   | VMS + 6p     | VMS + 6p           |
| Scan Method         | Measured     | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-23    | 2025-04-23    |
| psSAR1g [W/kg]      | 0.579         | 0.592         |
| psSAR10g [W/kg]     | 0.317         | 0.330         |
| Power Drift [dB]    | 0.01          | -0.00         |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 84.1          |
| Dist 3dB Peak [mm]  |               | 11.1          |



P44 WLAN 2.4G\_802.11b\_Rear Face\_1cm\_Ch1

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band        | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|-------------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | BACK, 10.00                  | WLAN 2.4GHz | WLAN, -    | 2412.000, 1                     | 7.7               | 1.8                    | 38.0             |

Hardware Setup

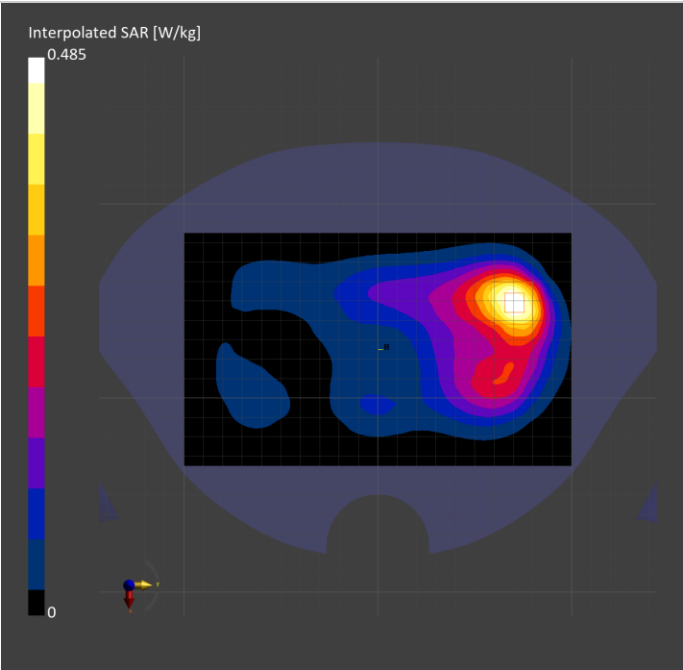
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL2450-2025-04-30 | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 200.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 10.0 x 10.0   | 5.0 x 5.0 x 1.5    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.5                |
| MAIA                | N/A           | N/A                |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-30    | 2025-04-30    |
| psSAR1g [W/kg]      | 0.392         | 0.384         |
| psSAR10g [W/kg]     | 0.208         | 0.199         |
| Power Drift [dB]    | 0.00          | -0.02         |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 78.9          |
| Dist 3dB Peak [mm]  |               | 12.6          |



P45 WLAN5G\_802.11a\_Top Side\_1cm\_Ch48

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band      | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|-----------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | EDGE TOP, 10.00              | WLAN 5GHz | WLAN, -    | 5240.000, 48                    | 5.18              | 4.58                   | 36.3             |

Hardware Setup

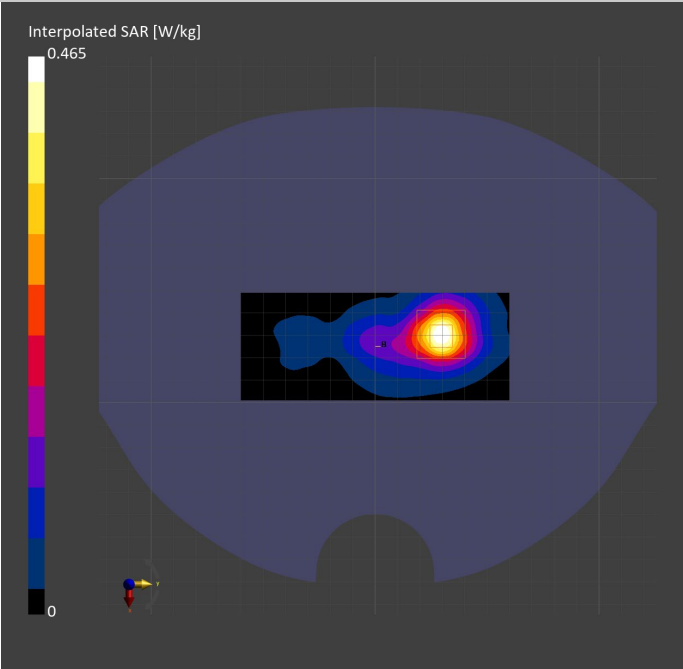
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL5G-2025-04-29   | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan    | Zoom Scan          |
|---------------------|--------------|--------------------|
| Grid Extents [mm]   | 48.0 x 120.0 | 22.0 x 22.0 x 22.0 |
| Grid Steps [mm]     | 8.0 x 10.0   | 4.0 x 4.0 x 1.4    |
| Sensor Surface [mm] | 3.0          | 1.4                |
| Graded Grid         | N/A          | Yes                |
| Grading Ratio       | N/A          | 1.4                |
| MAIA                | Y            | Y                  |
| Surface Detection   | VMS + 6p     | VMS + 6p           |
| Scan Method         | Measured     | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-29    | 2025-04-29    |
| psSAR1g [W/kg]      | 0.326         | 0.361         |
| psSAR10g [W/kg]     | 0.118         | 0.129         |
| Power Drift [dB]    | 0.14          | 0.10          |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 62.6          |
| Dist 3dB Peak [mm]  |               | 9.8           |



P46 WLAN5G\_802.11a\_Rear Face\_1cm\_Ch149

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band      | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|-----------|------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | BACK, 10.00                  | WLAN 5GHz | WLAN, -    | 5745.000, 149                   | 4.76              | 5.17                   | 35.4             |

Hardware Setup

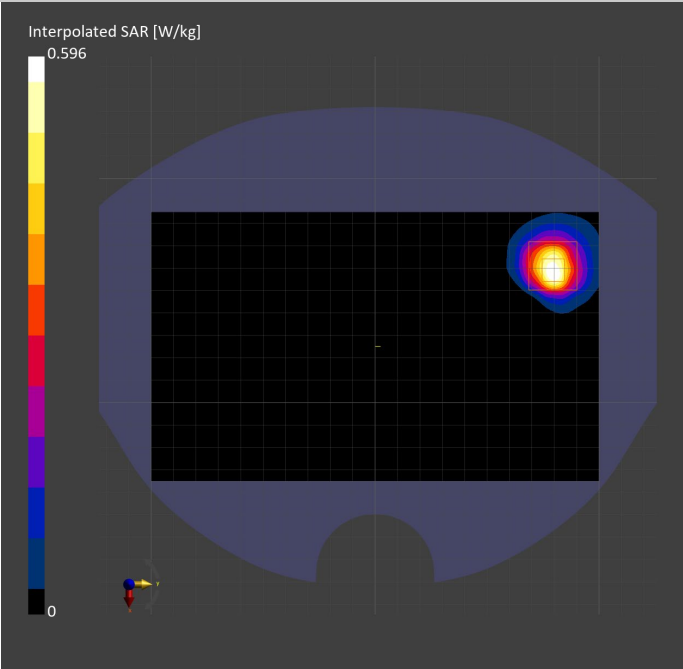
| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL5G-2025-04-30   | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 200.0 | 22.0 x 22.0 x 22.0 |
| Grid Steps [mm]     | 10.0 x 10.0   | 4.0 x 4.0 x 1.4    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.4                |
| MAIA                | Y             | Y                  |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-30    | 2025-04-30    |
| psSAR1g [W/kg]      | 0.427         | 0.426         |
| psSAR10g [W/kg]     | 0.143         | 0.143         |
| Power Drift [dB]    | -0.01         | -0.05         |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 60.7          |
| Dist 3dB Peak [mm]  |               | 8.6           |



P47 BT\_GFSK\_Rear Face\_1cm\_Ch39

Device under Test Properties

| Model, Manufacturer | Dimensions [mm]    | IMEI | DUT Type |
|---------------------|--------------------|------|----------|
| Device,             | 170.0 x 78.0 x 8.0 |      | Phone    |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band             | Group, UID   | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|----------------------|------------------------------|------------------|--------------|---------------------------------|-------------------|------------------------|------------------|
| Flat, -              | BACK, 10.00                  | ISM 2.4 GHz Band | Bluetooth, - | 2441.000, 39                    | 7.7               | 1.83                   | 37.9             |

Hardware Setup

| Phantom                                 | TSL, Measured Date | Probe, Calibration Date     | DAE, Calibration Date   |
|-----------------------------------------|--------------------|-----------------------------|-------------------------|
| Twin-SAM V8.0 (30deg probe tilt) - 2135 | HSL2450-2025-04-30 | EX3DV4 - SN7801, 2025-03-11 | DAE4 Sn1778, 2025-02-17 |

Scan Setup

|                     | Area Scan     | Zoom Scan          |
|---------------------|---------------|--------------------|
| Grid Extents [mm]   | 120.0 x 200.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm]     | 10.0 x 10.0   | 5.0 x 5.0 x 1.5    |
| Sensor Surface [mm] | 3.0           | 1.4                |
| Graded Grid         | N/A           | Yes                |
| Grading Ratio       | N/A           | 1.5                |
| MAIA                | Y             | Y                  |
| Surface Detection   | VMS + 6p      | VMS + 6p           |
| Scan Method         | Measured      | Measured           |

Measurement Results

|                     | Area Scan     | Zoom Scan     |
|---------------------|---------------|---------------|
| Date                | 2025-04-30    | 2025-04-30    |
| psSAR1g [W/kg]      | 0.044         | 0.037         |
| psSAR10g [W/kg]     | 0.023         | 0.019         |
| Power Drift [dB]    | -0.00         | 0.11          |
| Power Scaling       | Disabled      | Disabled      |
| Scaling Factor [dB] |               |               |
| TSL Correction      | No correction | No correction |
| M2/M1 [%]           |               | 78.1          |
| Dist 3dB Peak [mm]  |               | 11.2          |

